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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/058,263	01/25/2002	Milad F. Tabet	M-12468 US	4087
34036	7590 06/17/2004		EXAMINER	
	ALLEY PATENT GR	PUNNOOSE, ROY M		
2350 MISSION COLLEGE BOULEVARD SUITE 360			ART UNIT	PAPER NUMBER
SANTA CLA	ARA, CA 95054	2877		
			DATE MAILED: 06/17/2004	

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)				
	10/058,263	TABET, MILAD F.				
Office Action Summary	Examin r	Art Unit				
	Roy M. Punnoose	2877				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	66(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) days will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	ely filed will be considered timely. the mailing date of this communication. O (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on	·					
	<u> </u>					
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.						
Disposition of Claims						
 4) ☐ Claim(s) 1-14 is/are pending in the application. 4a) Of the above claim(s) is/are withdraw 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-14 is/are rejected. 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or 	vn from consideration.					
Application Papers						
9) The specification is objected to by the Examine	r,					
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction 11) The oath or declaration is objected to by the Ex						
Priority under 35 U.S.C. § 119						
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
Attachment(s)						
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) 	4) Interview Summary Paper No(s)/Mail Da	·				
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date <u>05/28/2004</u> .		atent Application (PTO-152)				

DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-14 are rejected under 35 U.S.C. 103(a) as being unpatentable over by Fanton et al (US 6,707,056 B2).
- 3. Claims 1, 5 and 11 are rejected because:
- A). Fanton et al (Fanton hereinafter) discloses an apparatus 15 and method comprising orienting a substrate 1 with respect to an ellipsometer, producing a light beam with an ellipsometer, said light beam creating an elliptical light spot (see light spot B, Figure 5) and measuring surface properties of a selected test area with said ellipsometer (see col.2, line48 col.3 line 9), a rotatable stage 19, 21 (see col.2, lines 49-50) for mounting said substrate 1, said apparatus and method for ellipsometrically measuring a test area on a substrate using an elliptical light spot produced by said ellipsometer for improving the measurements (see col. 1, lines 11-14) of a selected test area of a substrate under test. However, Fanton does not explicitly disclose that the elliptical light spot fit diagonally within a test area in an apparatus and method for ellipsometrically measuring a test area on a substrate using an elliptical light spot produced by said ellipsometer for improving the measurements of a selected test area of a substrate under test.
- B). Fanton teaches that the elliptical light spot position and orient a test area for making measurements of any test site and within said elliptical light spot (see col.3, lines 2-8) in an

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apparatus and method for ellipsometrically measuring a test area on a substrate using an elliptical light spot produced by said ellipsometer for improving the measurements of a selected test area of a substrate under test.

- C). In view of Fanton's teachings, it would have been obvious to one of ordinary skills in the art at the time the invention was made to incorporate a method where said elliptical light spot fit diagonally within a test area in an apparatus and method for ellipsometrically measuring a test area on a substrate using an elliptical light spot produced by said ellipsometer for improving the measurements of a selected test area of a substrate under test.
- 4. Claims 2-4, 6-10 and 12-14 are rejected because in view of Fanton's teachings as disclosed above, specifically about the rotatable stage 19, 21 (see col.3, lines 22-31) it would have been obvious to one of ordinary skills in the art at the time the invention was made to determine the angle of diagonal of the test area from the amount of rotation of the rotatable stage 19, 21 or to rotate the stage by a predetermined angle so that the major axis of the light spot is aligned with the angle of the diagonal of the test area.

Conclusion

5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to **Roy M. Punnoose** whose telephone number is **571-272-2427**. The examiner can normally be reached on 9:00 AM - 5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Frank G. Font can be reached on 571-272-2415. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Roy M. Punnoose Patent Examiner Art Unit 2877 June 13, 2004

Mr. Frank G. Font

Supervisory Patent Examiner